

Notice of References Cited

Application/Control No.

10/576,173

Applicant(s)/Patent Under
Reexamination
FUJITA ET AL.

Examiner

Christian Y. Jang

Art Unit

4153

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0236235	11-2004	Fujita et al.	600/500
*	B	US-2006/0247542	11-2006	Watanabe et al.	600/500
*	C	US-2002/0156392	10-2002	Arai et al.	600/546
	D	US-			
	E	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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